



SHEET 1 OF 9

INFORMATION DISCLOSURE STATEMENT BY APPLICANT  (Substitute for form 1449/PTO)			ATTY. DOCKET NO. <b>070456-0122</b>		SERIAL NO. <b>10/585,646</b>		
			APPLICANT <b>Yasuyuki WATANABE, et al.</b>		FILING DATE <b>July 07, 2006</b>		GROUP <b>Not Yet Assigned</b>
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EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code <sub>2</sub> ( <i>if known</i> )	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document		Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
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		JIS G 0551 "Methods of austenite grain size determination for steel", Published by Japanese Standards Association, February 20, 1998			
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EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code <sub>3</sub> -Number + Kind Codes ( <i>if known</i> )	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation Yes      No
		<b>JP 08-004774</b>	<b>01-09-1996</b>	<b>NTN TOYO BEARING CO LTD</b>		<b>JAPAN (w/ English Abstract)</b>
		<b>JP 11-101247</b>	<b>04-13-1999</b>	<b>NTN TOYO BEARING CO LTD</b>		<b>JAPAN (w/ English Abstract)</b>
		<b>DE 4 204 982 A1</b>	<b>08-26-1993</b>	<b>HOECHSTADTER MASCHINENFABRIKS (DE)</b>		<b>GERMANY (w/ English Abstract)</b>
		<b>EP 0 626 468 A1</b>	<b>11-30-1994</b>	<b>SKF IND TRADING &amp; DEV (NL)</b>		<b>X</b>
		<b>EP 0 723 034 A2</b>	<b>07-24-1996</b>	<b>DOWA MINING CO (JP)</b>		<b>X</b>
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				
		<b>JIS Z 2242 "Method of impact test for metallic materials", Published by Japanese Standards Association, December 21, 1998</b>				
		<b>JIS Z 2202 "Test pieces for impact test for metallic materials" Published by Japanese Standards Association, February 20, 1998</b>				
		<b>BURRIER, JR., H., "Hardenability of Carbon and Low-Alloy Steels", 2002, ASM International</b>				
		<b>VANDER VOORT, G., "Embrittlement of Steels", 2002 ASM International</b>				
		<b>KIM, C., et al., "Influence of Subzero and Shot-Peening Treatments on Impact and Fatigue Fracture Properties of Case-Hardened Steels", J. Heat Treat., June 1981, Pages 43-53, Vol 2 No 1</b>				
		<b>US Office Action, issued in US Patent Application No. 10/686,766, dated on November 7, 2007</b>				
		<b>US Office Action, issued in US Patent Application No. 10/787,221, dated on October 26, 2007</b>				
EXAMINER				DATE CONSIDERED		

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